LOCTITE ABLESTIK ABP 8068TB Data Package

Semi-sintering Die Attach Paste

Henkel Electronic Materials

WGQ/Apr 2018



Agenda

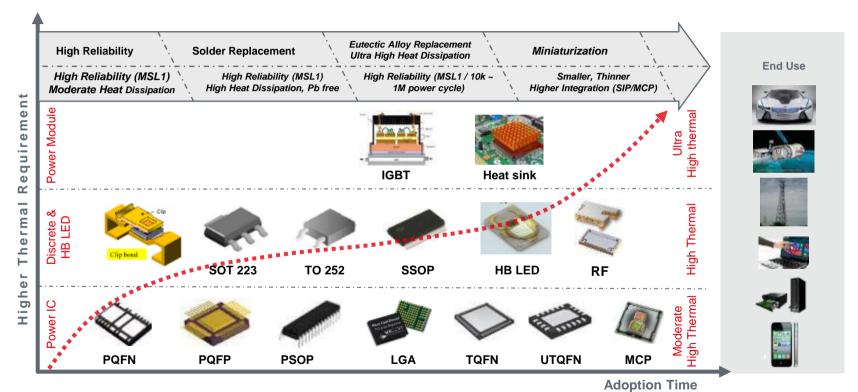
High Thermal DA Introduction	
ABP 8068TB Introduction	
Workability	
Void & Adhesion	
In Package Thermal Resistance & Reliability	

High Thermal DA Introduction

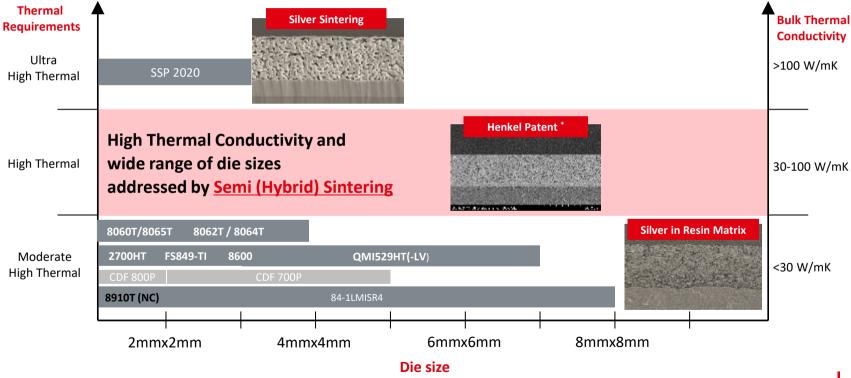


High Thermal DA Introduction

Applications for High Thermal Die Attach Pastes



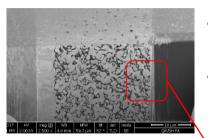
High Thermal DA Introduction Henkel Solution



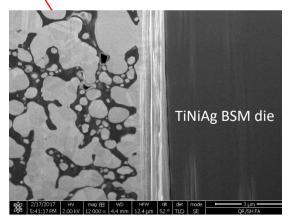
High Thermal DA Introduction

Difference of pure sintering & semi-sintering

ABP 8068TB cured @ 175°C

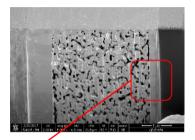


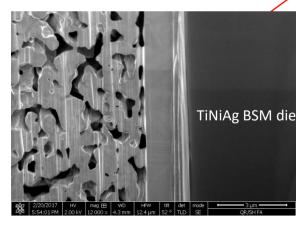
- Lower temperature sintering, no need of high pressure and temperature for sintering
- Void free bond lines



Full Sintering cured @ 220°C

- High temperature and pressure required for sintering
- Porous bond lines







ABP 8068TB Introduction



ABP 8068TB Introduction

Product Feature

- ABP 8068TB is a semi-sintering die attach paste designed for semiconductor devices which require ultra high thermal conductive adhesive. Typical application is die attach.
- It can provide below benefits for customers:
 - Robust, lead free solder alternative
 - Lower temperature sintering achieve pressure less sintering at lower temperature of 175°C to 200°C
 - Best in-class electrical and thermal performance
 - Bulk thermal conductivity up to 100 W/m·K
 - Low-in-package thermal resistance (R_{th}) ~ 0.5 K/W
 - It can be applied to a wide range of die size from 0.5x0.5 to 8x8mm regardless of die back side metallization – Ag, Au or TiNiAg
 - Processing similar to standard die attach pastes
 - Excellent workability, exceptional dispensing and printing
 - Longer work life of 16 hrs.
 - Stable open time of 2 hours
 - Robust adhesion
 - It achieves high adhesion on different lead frame finish including PPF, Au, Ag and bare Cu surface.



January 7, 2022

| ABP 8068TB Introduction

Typical Technical Data

ABP 8068TB Typical Technical Data						
Taskaralana		Recommended Cure profile <5*5mm	20min ramp to 130°C,hold 0.5-1h; +15min ramp to 200°C, hold 2h.			
Technology	Semi-Sintering	Recommended Cure profile >5*5mm	20min ramp to 130°C,hold 2h; +15min ramp to 200°C, hold 2h.			
Chemistry	Ероху	Weight Loss on Cure, by TGA	4.0%			
Filler type	Silver	Bulk Thermal Conductivity (W/mK)	100			
Density, g/ml	5.6	Volume Resistivity (Ohm·cm)	7 x 10 ⁻⁶			
Viscosity @ 25ºC (cps), 5rpm, CP51	11,500	Tg by TMA	25 ºC			
Thixotropic Index, 0.5rpm/5rpm	5.5	CTE1 (ppm/ºC)	25			
Open time, 1x1mm die	2hrs	CTE2 (ppm/ºC)	103			
Stage time, 3x3mm die	>=4hrs	Modulus @25ºC (GPa)	12.5			
Work Life @ 25ºC	16hrs	Modulus @150ºC (GPa)	1.1			
Recommended Storage Temperature	-40 ºC	Modulus @250ºC (GPa)	0.65			
Storage Life (@ -40ºC)	1year	Tg by DMA	66 ºC			
Elongation @ break, RT	5.0%					



Manufacturability Test

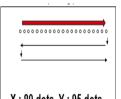


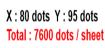
Dispensing Performance Continuous "dot" dispense

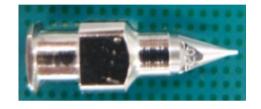
Condition for Dot Dispensing:

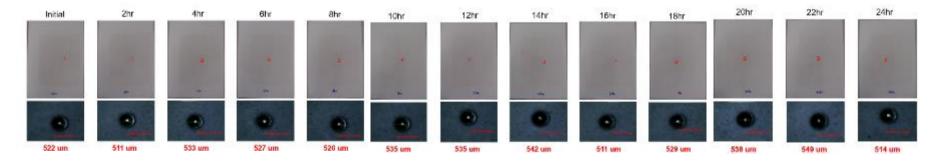
CAMALOT - pneumatic dispenser

- Air pressure @ 6 psi
- Musashi conical needle (HN), ID: 200um
- Continuous dot dispensing on OHP film (A4 size)
 ~500um diameter
- Total dispense: ~100K dots









No missing dot observed up to even 24hrs

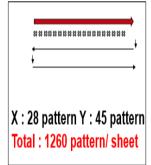


Dispensing Performance Continuous "X pattern" dispense

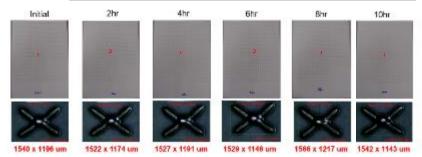
Condition for X Pattern Dispensing:

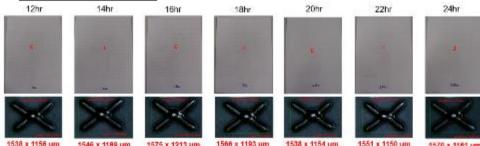
Musashi Super ΣCM II – pneumatic dispenser

- Air pressure @ 6.5 psi
- Musashi conical needle (HN), ID: 200um
- Continuous dot dispensing on OHP film (A4 size, ~1.5 x 1.1 mm
- Total dispense : ~ 17K pattern



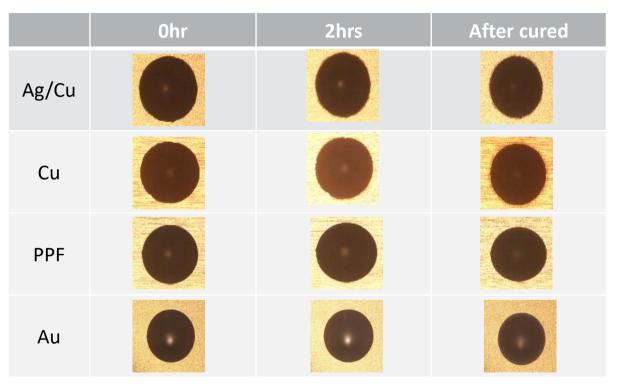






- No missing pattern observed up to even 24hrs
- Consistent volume with continuous dispensing

Bleed Performance



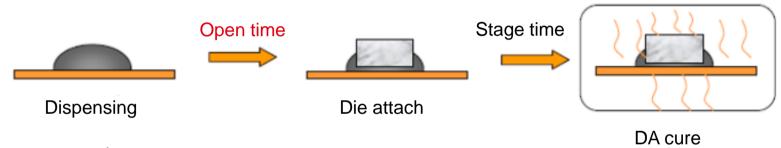
Good bleed performance on all surface, though slight RBO on Cu surface



Workability

Open Time

• Open time: The time after dispending before die attach. At that time the paste is open to the environment.



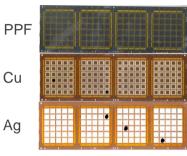
- Cure condition
 - Profile 1 (N2): 20min ramp to 130C, hold 30min + 15min ramp to 200C, hold 2hrs
 - Profile 2 (Air): 20min ramp to 130C, hold 30min + 15min ramp to 200C, hold 2hrs
- Die Shear:
 - HT DSS @ 260°C set temperature



Workability

Open Time

- Adhesives
 - Semi-sintering paste: ABP8068TB
 - Bath #:X09AUG17A
- QFN Lead-frame (7x7mm)
 - Ag & PPF
- Chip
 - Die Size: 1x1mm x 0.381
 - Back side Metallization: Ti-Ni-Ag
- EFD Needle ID
 - 0.2mm



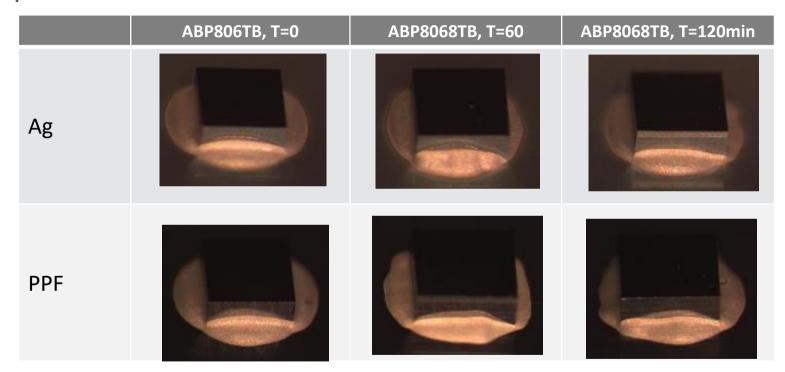
QFN lead-frame



EFD needle



Workability Open Time



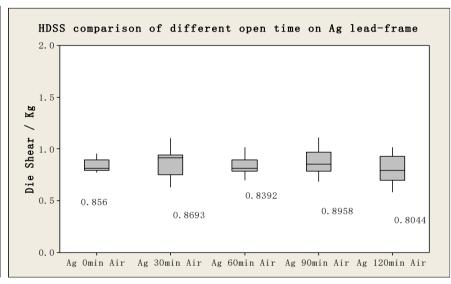
ABP 8068TB can maintain stable fillet/coverage even up to 2 hours open time

Workability Open Time

N2 cure

HDSS comparison of different open time on Ag lead-frame 2.0 1.5 1.5 0.9812 0.9772 0.948 0.9734 0.9245 0.9245

Air cure

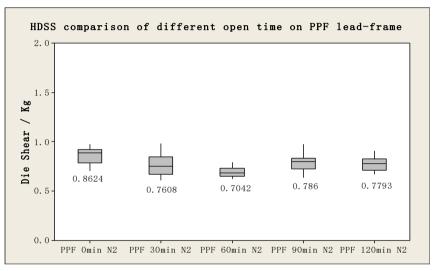


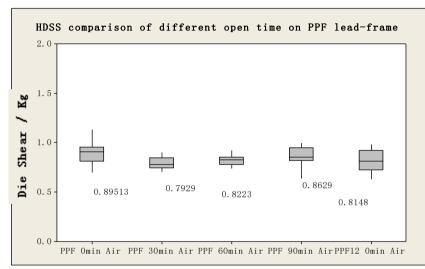
ABP 8068TB can maintain stable HT DSS even after 2 hours open time on Ag LF

Workability Open Time

N2 cure

Air cure

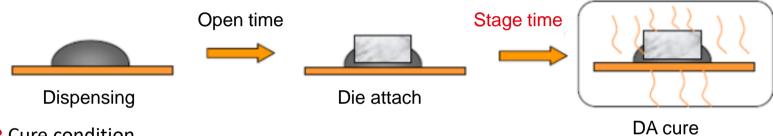




ABP 8068TB can maintain stable HT DSS even after 2 hours open time on PPFLF

Workability Stage Time

• Stage time: The time after die attach and before curing in oven.



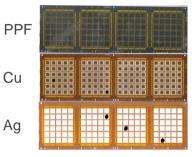
- Cure condition
 - Profile 1 (N2): 20min ramp to 130C, hold 30min + 15min ramp to 200C, hold 2hrs
 - Profile 2 (Air): 20min ramp to 130C, hold 30min + 15min ramp to 200C, hold 2hrs
- Die Shear:
 - RTDSS: room temp. die shear
 - HTDSS: 260°C hot temp. die shear
 - Pb HTDSS: 260°C hot temp. die shear after Pb (121°C, 2atm, 100%RH 16 hours)



Workability

Stage Time

- Adhesives
 - Semi-sintering paste: ABP 8068TB
 - Bath #:X06DEC17A
- QFN Lead-frame (7x7mm)
 - PPF
- Chip
 - Die Size: 3x3mm x 0.381
 - Back side Metallization: Ti-Ni-Ag
- EFD Needle ID
 - 0.2mm



QFN lead-frame



EFD needle



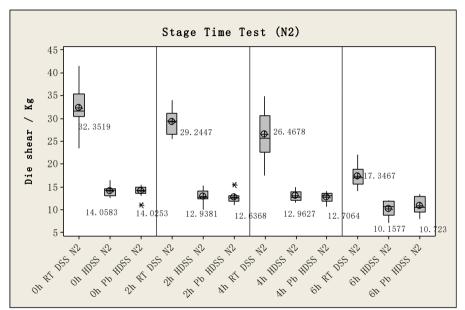
Workability Stage Time

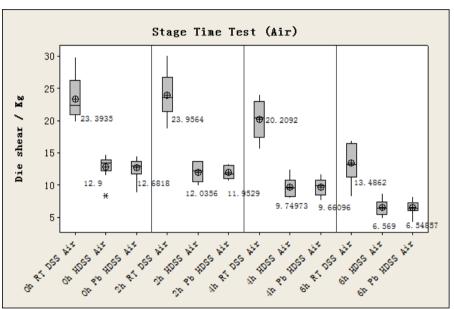
Test item	0h	2hr	4hr	6hr
	After cure	After cure	After cure	After cure
X-ray				
Coverage				
Fillet height				

BLT≈ 18um. Both air & N2 no voids detected

ABP 8068TB shows zero voids even after 6 hours of staging in N2 curing

Workability Stage Time





- ABP 8068TB show strong adhesion even after 4 hours in either N₂ or air cure condition
 - Noted a decline at 6 hours however still relatively have high adhesive value



Workability

Work Life

8068TB Worklife test data (@ 25°C)							
Tim	е	Fresh	16H	24H	32H	48H	
viscosity@5	orpm (cP)	10850	13920	14830	16240	17480	
viscosity i	ncrease_	-	28.29%	36.68%	49.68%	61.10%	
Volume resistar	nce (Ohm.cm)	5.60E-06	5.50E-06	5.70E-06	5.50E-06	6.00E-06	
	Sample #1	4	6.1	5.4	4.7	5.5	
	Sample #2	5.3	6.2	6	5.2	5.4	
	Sample #3	5.4	7.3	5.9	7.2	4.2	
36040aC DCC	Sample #4	6	7	6.4	6.9	6.9	
260degC DSS (2X2mm Die),Kg	Sample #5	5.7	5.8	5.6	6.3	6.4	
(ZAZIIIII Diej,kg	Sample #6	5.9	5.7	6.3	6.4	6.6	
	Sample #7	6.7	5.4	5.8	6.6	6.4	
	Sample #8	5.9	5.7	5.4	6.4	5.3	
	Average	5.61	6.15	5.85	6.21	5.84	
Average dot	t size/mm	0.953	0.884	0.875	0.856	0.805	

^{*}Henkel work life reference: viscosity increase <=50%

ABP 8068TB has 16 hours recommended work life*



^{*}A corner batch with high increase of viscosity was selected for testing

Workability Summary

ABP8068TB exhibited:

- Good resin bleeding control on different leadframe surface
- Stable and consistent dispensing. No missing dot or missing line was observed even up to 24hrs continuous dispensing
- Stable "open" time even up to 2 hours
- Stable "staging" time: recommend 4 hours
- Recommended work life of 16 hours

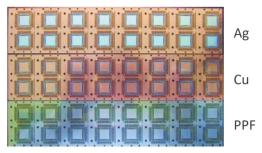
Void and Adhesion



Void & Adhesion

Test Vehicle

- Adhesives
 - Semi-sintering paste: ABP8068TB
 - Bath #:X05JAN18A
- QFP Lead-frame (10x10mm)
 - Cu, Ag, PPF
- Chip
 - Die Size: 1x1mm, 3X3mm, 5X5mm
 - Back side Metallization: Ti-Ni-Ag
 - Die thickness: 381um
- EFD Needle ID: 0.3mm



QFP lead-frame

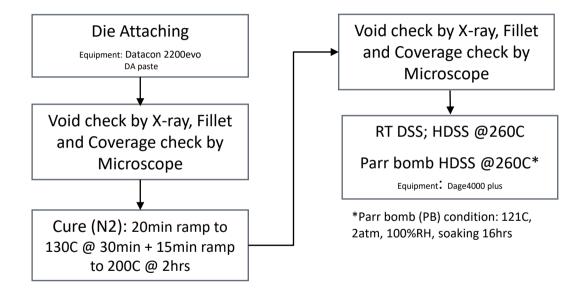


EFD needle



Void & Adhesion

Test Flow



Void and Adhesion

1x1mm Die

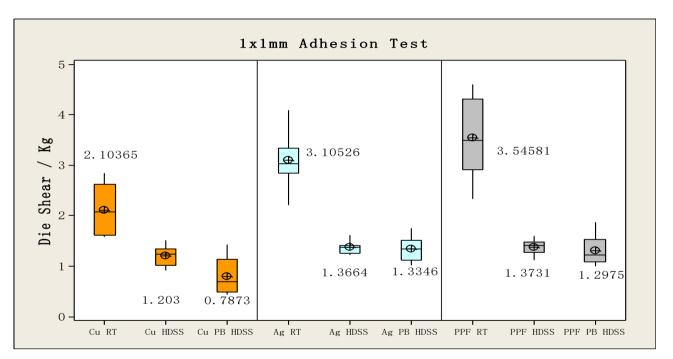
Test item	Cu	Ag	PPF
rest item	After cure	After cure	After cure
X-ray		0	Channel void
Coverage			
Fillet height			

- On 1x1mm die, when wet BLT is lower than 10um, channel void was observed.
- Henkel recommends a wet BLT of >10um



Void & Adhesion

1x1mm Die



ABP 8068TB has good adhesion performance on Cu, Ag & PPF lead-frame.

Void & Adhesion 1x1mm Die

Failure Mode

Test item	Cu	Ag/Cu	PPF	
	Failure mold	Failure mold	Failure mold	
RTDSS	00			
260C HDSS	conesive)	eshe sive	on established	
260C Pb HDSS				

Void & Adhesion

3x3mm Die

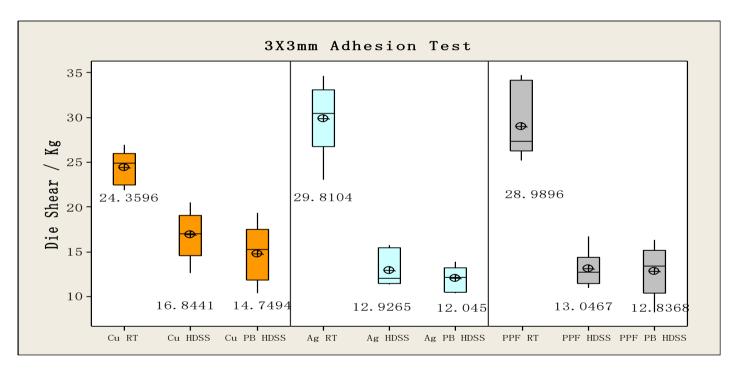
Test item	Cu	Ag/Cu	PPF
rest item	After cure	After cure	After cure
X-ray			
Coverage			
Fillet height			

- ABP 8068TB shows zero voids on 3 x 3 mm die
 - BLT controlled at 25um



Void & Adhesion

3x3mm Die



ABP 8068TB has good adhesion performance on Cu, Ag & PPF lead-frame.

Void & Adhesion 3x3mm Die

Failure Mode

Test item	Cu	Ag/Cu	PPF
	Failure mold	Failure mold	Failure mold
RTDSS			
260C HDSS	Patia coresiue	cohesive	Conesive
260C Pb HDSS		00	

Void & Adhesion 5x5mm Die

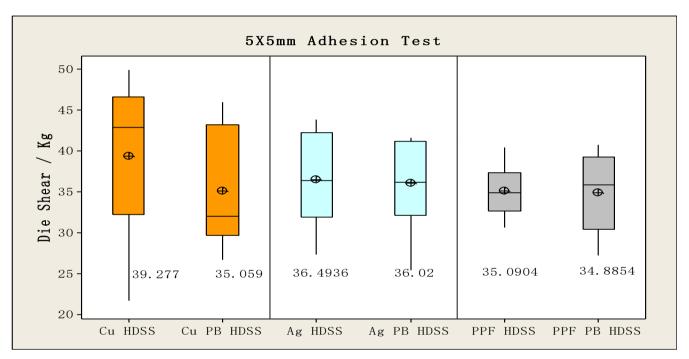
Test item	Cu	Ag/Cu	PPF
rest item	After cure	After cure	After cure
X-ray			
Coverage			
Fillet height			

- ABP 8068TB shows zero voids on 5 x 5 mm die
 - BLT controlled at 25um
 Henkel Proprietary and Confidential Information



Void & Adhesion

5x5mm Die



ABP 8068TB has good adhesion performance on Cu, Ag & PPF lead-frame.

^{*} RT DSS is too higher to test

Void & Adhesion 5x5mm Die

Failure Mode

Test item	Cu	Ag/Cu	PPF
	Failure mold	Failure mold	Failure mold
260C HDSS	Collegive	ohesive	cotesive
260C Pb HDSS	Paris	Const	conse

Void & Adhesion Summary

ABP8068TB exhibited:

- Void free bond line when BLT is controlled at 25um. Zero voids observed on big die size upto 5x5 mm
- Excellent adhesion on PPF and Ag LF. Adhesion on Cu LF is slightly lower however still exhibited good level of adhesion. Noted cohesive failure mode on Ag and PPF while partial cohesive failure mode on Cu LF.

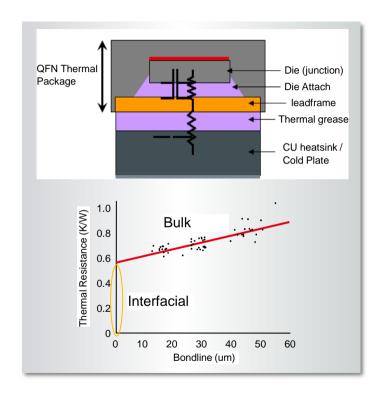
In Package Thermal Resistance



In Package Thermal Resistance Introduction

- Thermal Conductivity [W/mK] is an intrinsic material property
- Thermal Resistance, R_{th} [K/W], is a geometry dependent value that allows us to better compare materials in a functional package
 - 70 90% of the R_{th} is due to the interfaces and is not captured in thermal conductivity values

Interfacial Conductivity, Rather than Bulk Properties Has the Highest Impact on Thermal Performance

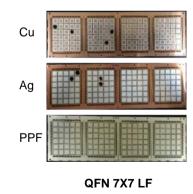


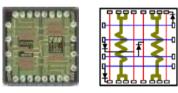


In package Thermal Resistance

Test Vehicle

- Die: thermal resistance test function die, 2.54mmx2.54mm, 15mil thickness, Au backside
- Package: QFN 7X7, Ag & PPF lead frame
- 1 mil gold wire
- Molding compound: Sumitomo EME-G770HCD





Functional die

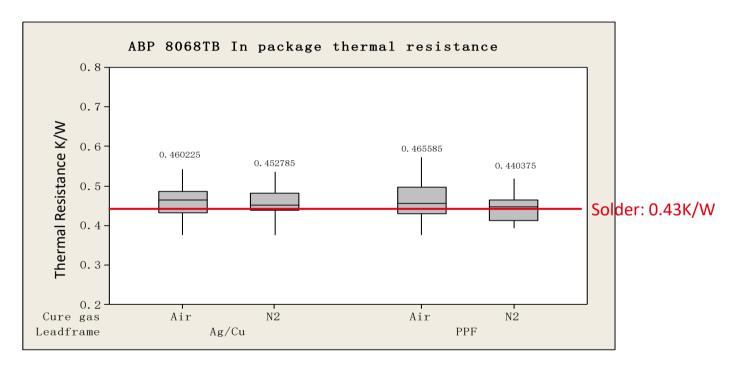
Electrical – Heating : TTC-1002 # of Resistors : 2 Resistance Value : 7.6 $\Omega \pm$ 10 % (each resistor)

Resistance Variation : \pm 5 % (for die from a specific wafer)

Max Resistor Power: 6 W (6V @ 1A) each

In Package Thermal Resistance

Result



Excellent in package thermal performance, comparable to solder



Semi (Hybrid) Sintering Paste

ABP 8068TB External Reliability Data

Package Type	Die Size (mm)	Die Thickness	Die BSM	L/F Finish	MSL1	MSL2A	MSL 3	тст	HTS 1000hrs (150C)	uHAST (130C/85%)
QFN	2.4X1.6	160um	TiNiAg	Cu	PASS					
LGA	0.5X0.5~1X1	100~200	Au	Au			PASS	PASS 500 (-55C/+125C)		PASS
SiP	1.2x0.9	75um (GaAs)	Au	Au		PASS	PASS	PASS 1000 (-55C/+125C)	PASS	PASS (96hrs)
SiP	1.2x0.9	75um (GaAs)	Au	Au			PASS	PASS (-55C/+125C)	PASS	PASS (96hrs)
SiP	1.3x0.6	75um (GaAs)	Au	Au		PASS	PASS	PASS (-55C/+125C)	PASS	PASS (96hrs)
SiP	1.3x0.6	75um (GaAs)	Au	Au			PASS	PASS (-55C/+125C)	PASS	PASS (96hrs)
SiP	2.0x1.0	(GaAs)	Au	Au			PASS			
SiP	2.0x2.0		Ag	Au			PASS			
LGA	4.0x3.0	200um	Au	Ag			PASS			



ABP8068TB Summary

- Henkel has supplemented its portfolio of die attach paste solutions with a novel semi-sintering, ultra-high thermal, conductive die attach portfolio.
- These solutions can be applied using processes similar to those employed with standard die attach pastes – no need of high temperature and pressure for sintering
- This technology delivers a robust, lead-free solder alternative solution with best-in-class electrical and thermal performance. These materials have lower inpackage thermal resistance than many standard die attach pastes on silver, copper and PPF lead frames
- LOCTITE ABLESTIK ABP 8068TB is the next product in the family, with focus on reducing resin bleed on roughened and ceramic substrates.



Thank you!



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